

# BUK7C06-40AITE

N-channel TrenchMOS standard level FET

Rev. 04 — 23 June 2005

Product data sheet

## 1. Product profile

### 1.1 General description

N-channel enhancement mode power Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology, featuring very low on-state resistance and including TrenchPLUS current sensing, and diodes for ElectroStatic Discharge (ESD) and overtemperature protection.

### 1.2 Features

- Q101 compliant
- ESD protection
- Integrated temperature sensor
- Integrated current sensor

### 1.3 Applications

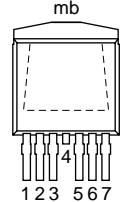
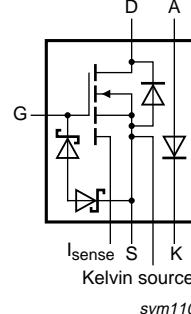
- Variable valve timing for engines
- Automotive and power switching
- Electrical power assisted steering
- Fan control

### 1.4 Quick reference data

- $V_{DS} \leq 40$  V
- $I_D \leq 155$  A
- $R_{DSon} = 4.7$  m $\Omega$  (typ)
- $V_F = 658$  mV (typ)
- $S_F = -1.54$  mV/K (typ)
- $I_D/I_{sense} = 615$  (typ)

## 2. Pinning information

Table 1: Pinning

Pin	Description	Simplified outline	Symbol
1	gate (G)		
2	$I_{sense}$		
3	anode (A)		
4	drain (D)		
5	cathode (K)		
6	kelvin source		
7	source (S)		
mb	mounting base; connected to drain (D)	 SOT427 (D2PAK)	 sym110

**PHILIPS**

### 3. Ordering information

**Table 2:** Ordering information

Type number	Package			Version
	Name	Description		
BUK7C06-40AITE	D2PAK	Plastic single-ended surface mounted package; 7 leads (one lead cropped)		SOT427

### 4. Limiting values

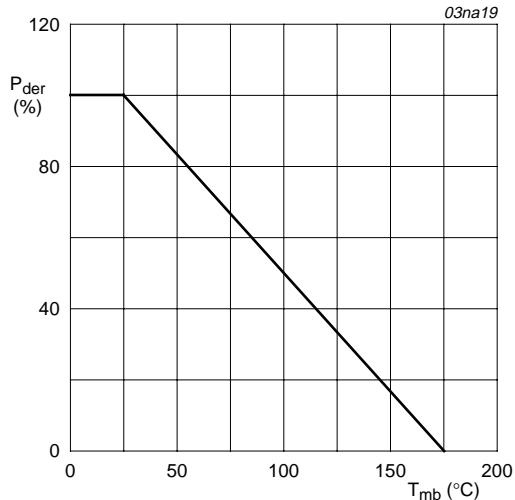
**Table 3:** Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{DS}$	drain-source voltage		-	40	V
$V_{DGR}$	drain-gate voltage (DC)	$R_{GS} = 20 \text{ k}\Omega$	-	40	V
$V_{GS}$	gate-source voltage		-	$\pm 20$	V
$I_D$	drain current	$T_{mb} = 25^\circ\text{C}; V_{GS} = 10 \text{ V}$ ; see <a href="#">Figure 2</a> and <a href="#">3</a>	[1] -	155	A
			[2] -	75	A
		$T_{mb} = 100^\circ\text{C}; V_{GS} = 10 \text{ V}$ ; see <a href="#">Figure 2</a>	[2] -	75	A
$I_{DM}$	peak drain current	$T_{mb} = 25^\circ\text{C}$ ; pulsed; $t_p \leq 10 \mu\text{s}$ ; see <a href="#">Figure 3</a>	-	620	A
$P_{tot}$	total power dissipation	$T_{mb} = 25^\circ\text{C}$ ; see <a href="#">Figure 1</a>	-	272	W
$I_{GS(CL)}$	gate-source clamping current	continuous	-	10	mA
		$t_p = 5 \text{ ms}; \delta = 0.01$	-	50	mA
$V_{isol(FET-TSD)}$	FET to temperature sense diode isolation voltage		-	$\pm 100$	V
$T_{stg}$	storage temperature		-55	+175	$^\circ\text{C}$
$T_j$	junction temperature		-55	+175	$^\circ\text{C}$
<b>Source-drain diode</b>					
$I_{DR}$	reverse drain current	$T_{mb} = 25^\circ\text{C}$	[1] -	155	A
			[2] -	75	A
$I_{DRM}$	peak reverse drain current	$T_{mb} = 25^\circ\text{C}$ ; pulsed; $t_p \leq 10 \mu\text{s}$	-	620	A
<b>Avalanche ruggedness</b>					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	unclamped inductive load; $I_D = 75 \text{ A}$ ; $V_{DS} \leq 40 \text{ V}$ ; $V_{GS} = 10 \text{ V}$ ; $R_{GS} = 50 \Omega$ ; starting at $T_j = 25^\circ\text{C}$	-	1.46	J
<b>Electrostatic discharge</b>					
$V_{esd}$	electrostatic discharge voltage, pins 1, 2, 4, 6, 7	Human Body Model; $C = 100 \text{ pF}$ ; $R = 1.5 \text{ k}\Omega$	-	6	kV

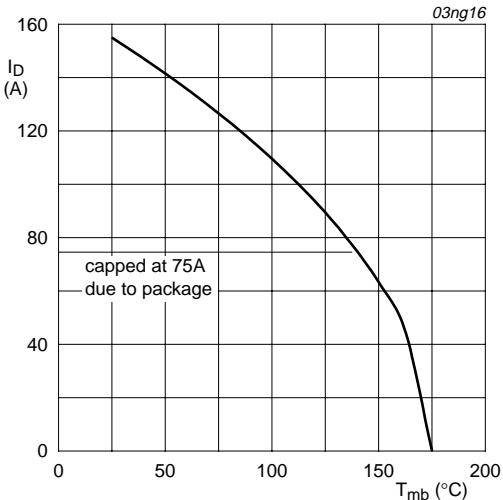
[1] Current is limited by power dissipation chip rating.

[2] Continuous current is limited by package.



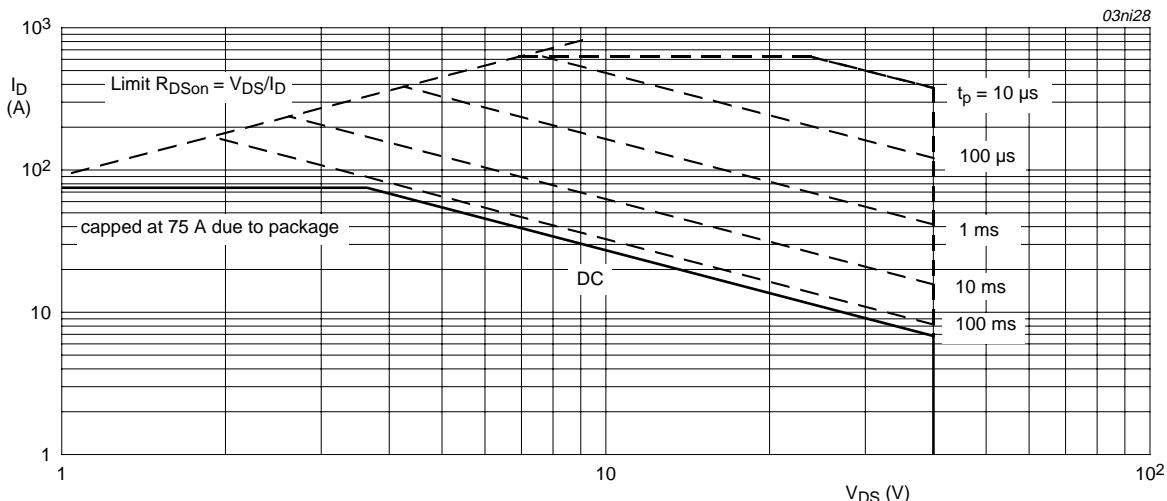
$$P_{der} = \frac{P_{tot}}{P_{tot}(25^{\circ}\text{C})} \times 100 \%$$

**Fig 1. Normalized total power dissipation as a function of mounting base temperature**



V<sub>GS</sub> ≥ 10 V

**Fig 2. Continuous drain current as a function of mounting base temperature**



T<sub>mb</sub> = 25 °C; I<sub>DM</sub> single pulse

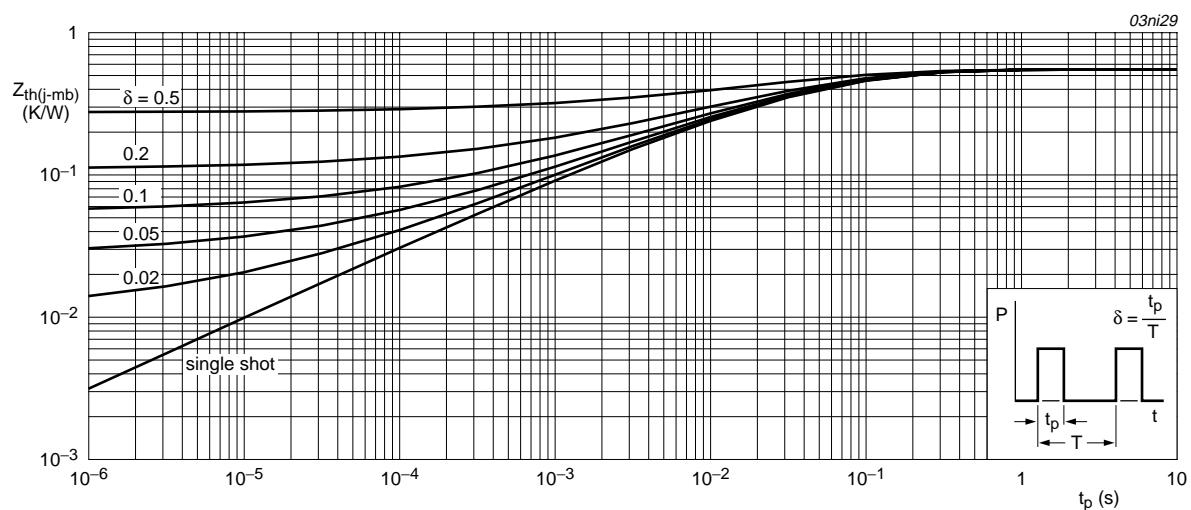
**Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage**

## 5. Thermal characteristics

**Table 4: Thermal characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	[1]	-	-	50	K/W
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	-	0.55	K/W

[1] Mounted on printed-circuit board; minimum footprint



**Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration**

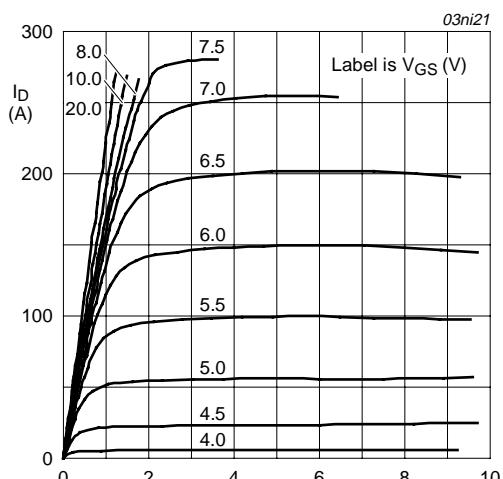
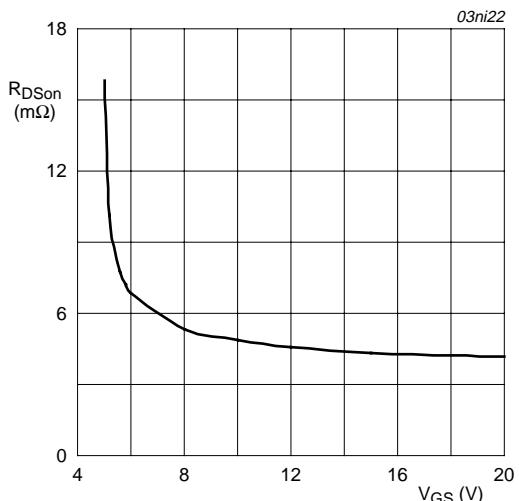
## 6. Characteristics

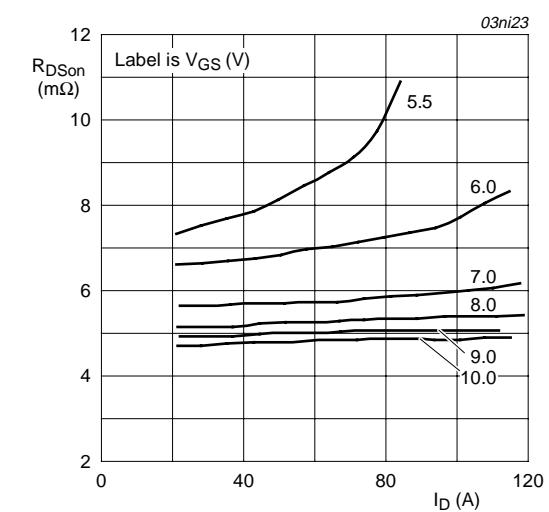
**Table 5: Characteristics** $T_j = 25^\circ\text{C}$  unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static characteristics</b>						
$V_{(\text{BR})\text{DSS}}$	drain-source breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}$ $T_j = 25^\circ\text{C}$ $T_j = -55^\circ\text{C}$	40	-	-	V
$V_{GS(\text{th})}$	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$ ; see <a href="#">Figure 9</a> $T_j = 25^\circ\text{C}$ $T_j = 175^\circ\text{C}$ $T_j = -55^\circ\text{C}$	2	3	4	V
$I_{DSS}$	drain leakage current	$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}$ $T_j = 25^\circ\text{C}$ $T_j = 175^\circ\text{C}$	-	0.1	10	$\mu\text{A}$
$V_{(\text{BR})\text{GSS}}$	gate-source breakdown voltage	$I_G = \pm 1 \text{ mA}; -55^\circ\text{C} < T_j < +175^\circ\text{C}$	20	22	-	V
$I_{GSS}$	gate leakage current	$V_{GS} = \pm 10 \text{ V}; V_{DS} = 0 \text{ V}$ $T_j = 25^\circ\text{C}$ $T_j = 175^\circ\text{C}$	-	22	1000	nA
$R_{DS\text{on}}$	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A}$ ; see <a href="#">Figure 7</a> and <a href="#">8</a> $T_j = 25^\circ\text{C}$ $T_j = 175^\circ\text{C}$	-	4.7	6	$\text{m}\Omega$
$V_F$	forward voltage of temperature sense diode	$I_F = 250 \mu\text{A}$	648	658	668	mV
$S_F$	temperature coefficient of temperature sense diode	$I_F = 250 \mu\text{A}; -55^\circ\text{C} < T_j < +175^\circ\text{C}$	-1.4	-1.54	-1.68	$\text{mV/K}$
$V_{\text{hys}}$	forward voltage hysteresis of temperature sense diode	$125 \mu\text{A} < I_F < 250 \mu\text{A}$	25	32	50	mV
$I_D/I_{\text{sense}}$	ratio of drain current to sense current	$V_{GS} = 10 \text{ V}; -55^\circ\text{C} < T_j < +175^\circ\text{C}$	585	615	645	
<b>Dynamic characteristics</b>						
$Q_{G(\text{tot})}$	total gate charge	$V_{GS} = 10 \text{ V}; V_{DS} = 32 \text{ V}; I_D = 25 \text{ A}$ ; see <a href="#">Figure 14</a>	-	120	-	nC
$Q_{GS}$	gate-source charge	$V_{GS} = 10 \text{ V}; V_{DS} = 32 \text{ V}; I_D = 25 \text{ A}$ ; see <a href="#">Figure 14</a>	-	19	-	nC
$Q_{GD}$	gate-drain charge	$V_{GS} = 10 \text{ V}; V_{DS} = 32 \text{ V}; I_D = 25 \text{ A}$ ; see <a href="#">Figure 14</a>	-	50	-	nC
$C_{iss}$	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$ ; see <a href="#">Figure 12</a>	-	4300	-	pF
$C_{oss}$	output capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$ ; see <a href="#">Figure 12</a>	-	1400	-	pF
$C_{rss}$	reverse transfer capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$ ; see <a href="#">Figure 12</a>	-	820	-	pF

**Table 5: Characteristics ...continued** $T_j = 25^\circ\text{C}$  unless otherwise specified.

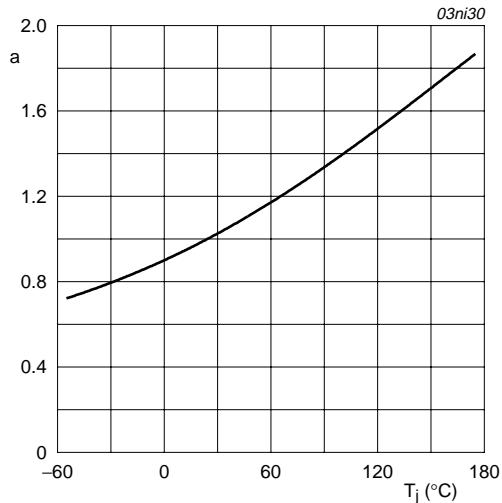
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$t_{d(on)}$	turn-on delay time	$V_{DD} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 10 \text{ V}; R_G = 10 \Omega$	-	35	-	ns
$t_r$	rise time	$V_{DD} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 10 \text{ V}; R_G = 10 \Omega$	-	115	-	ns
$t_{d(off)}$	turn-off delay time	$V_{DD} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 10 \text{ V}; R_G = 10 \Omega$	-	155	-	ns
$t_f$	fall time	$V_{DD} = 30 \text{ V}; R_L = 1.2 \Omega; V_{GS} = 10 \text{ V}; R_G = 10 \Omega$	-	110	-	ns
$L_D$	internal drain inductance	measured from upper edge of drain mounting base to center of die	-	2.5	-	nH
$L_S$	internal source inductance	measured from source lead to source bond pad	-	7.5	-	nH
<b>Source-drain diode</b>						
$V_{SD}$	source-drain (diode forward) voltage	$I_S = 40 \text{ A}; V_{GS} = 0 \text{ V}$ ; see <a href="#">Figure 18</a>	-	0.85	1.2	V
$t_{rr}$	reverse recovery time	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A}/\mu\text{s}; V_{GS} = -10 \text{ V}; V_{DS} = 30 \text{ V}$	-	96	-	ns
$Q_r$	recovered charge	$I_S = 20 \text{ A}; dI_S/dt = -100 \text{ A}/\mu\text{s}; V_{GS} = -10 \text{ V}; V_{DS} = 30 \text{ V}$	-	224	-	nC

 $T_j = 25^\circ\text{C}; t_p = 300 \mu\text{s}$ **Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values** $T_j = 25^\circ\text{C}; I_D = 50 \text{ A}$ **Fig 6. Drain-source on-state resistance as a function of gate-source voltage; typical values**



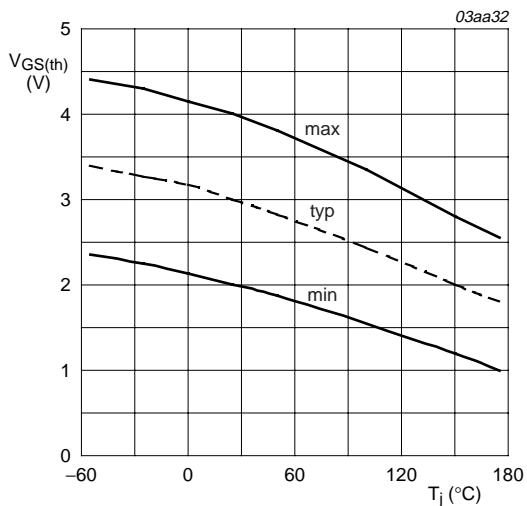
T<sub>j</sub> = 25 °C; t<sub>p</sub> = 300 μs

**Fig 7. Drain-source on-state resistance as a function of drain current; typical values**



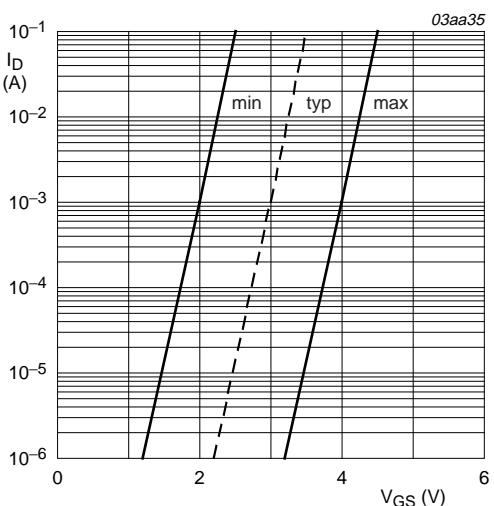
$$a = \frac{R_{DSon}}{R_{DSon}(25^\circ C)}$$

**Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature**



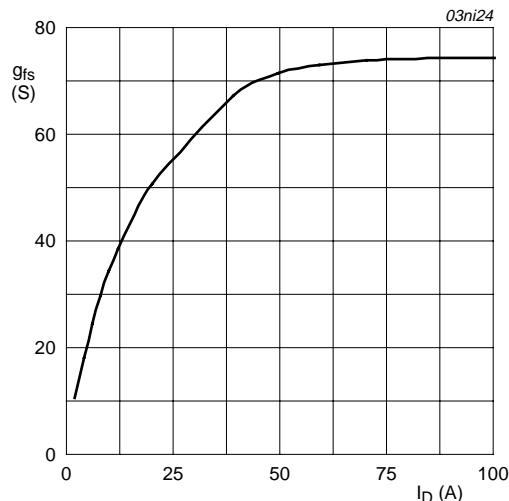
I<sub>D</sub> = 1 mA; V<sub>DS</sub> = V<sub>GS</sub>

**Fig 9. Gate-source threshold voltage as a function of junction temperature**



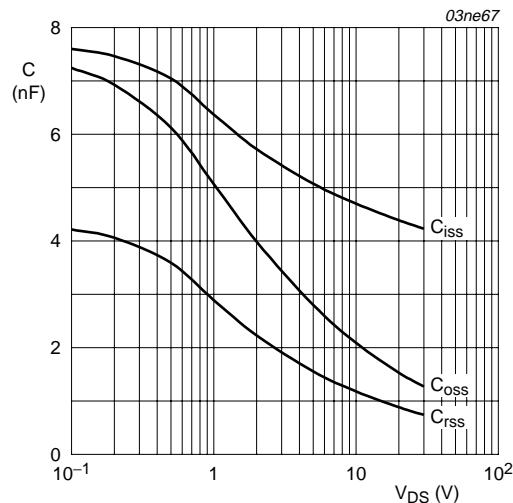
T<sub>j</sub> = 25 °C; V<sub>DS</sub> = V<sub>GS</sub>

**Fig 10. Sub-threshold drain current as a function of gate-source voltage**



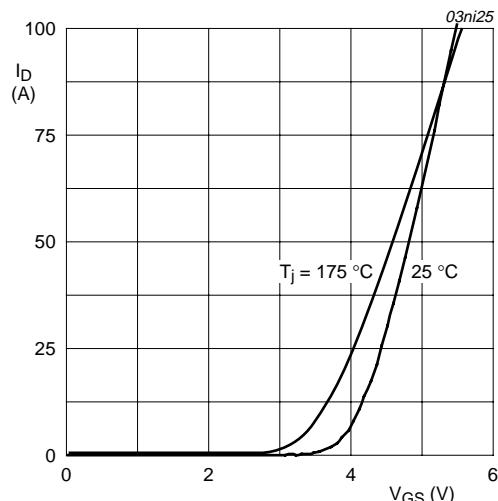
$T_j = 25^\circ\text{C}$ ;  $V_{DS} = 25\text{ V}$

**Fig 11. Forward transconductance as a function of drain current; typical values**



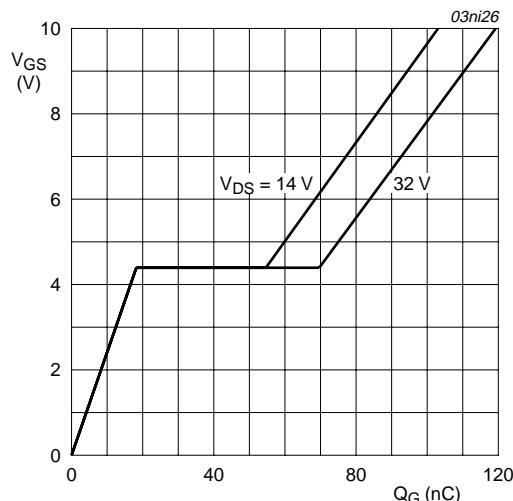
$V_{GS} = 0\text{ V}$ ;  $f = 1\text{ MHz}$

**Fig 12. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values**



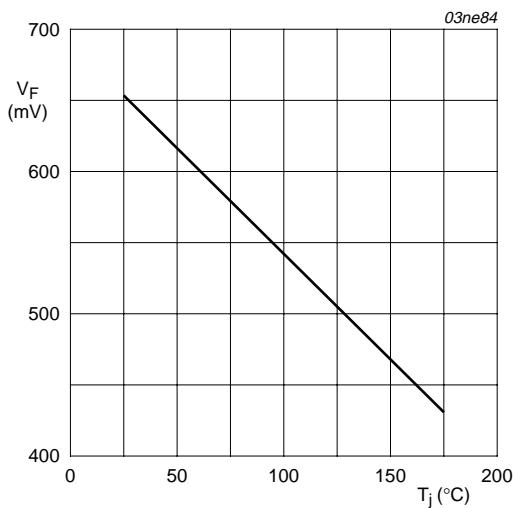
$V_{DS} = 25\text{ V}$

**Fig 13. Transfer characteristics: drain current as a function of gate-source voltage; typical values**

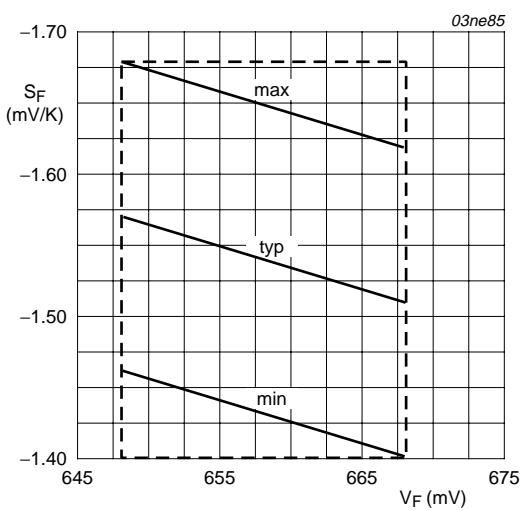


$T_j = 25^\circ\text{C}$ ;  $I_D = 25\text{ A}$

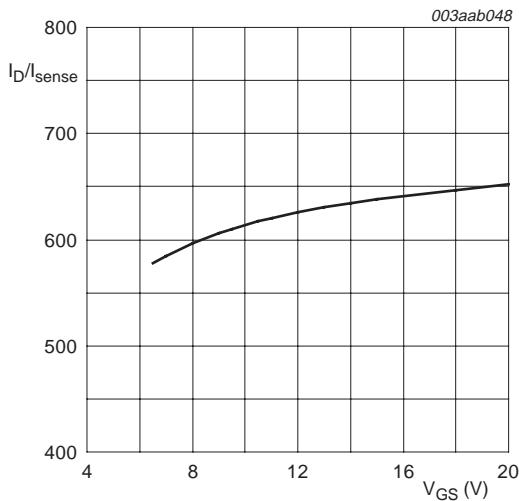
**Fig 14. Gate-source voltage as a function of turn-on gate charge; typical values**

 $I_F = 250 \mu\text{A}$ 

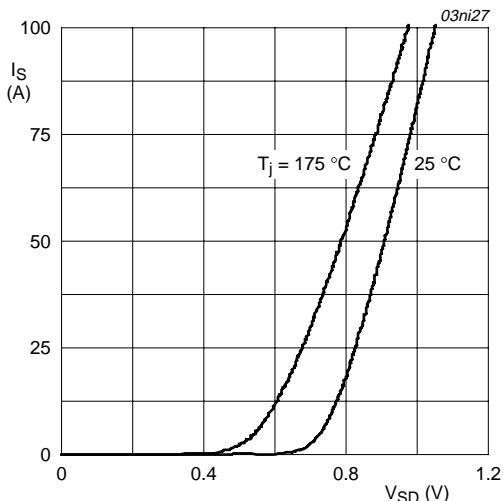
**Fig 15. Forward voltage of temperature sense diode as a function of junction temperature; typical values**

 $V_F$  at  $T_j = 25$  °C;  $I_F = 250 \mu\text{A}$ 

**Fig 16. Temperature coefficient of temperature sense diode as a function of forward voltage; typical values**

 $I_D = 25$  A

**Fig 17. Drain-sense current ratio as a function of gate voltage; typical values**

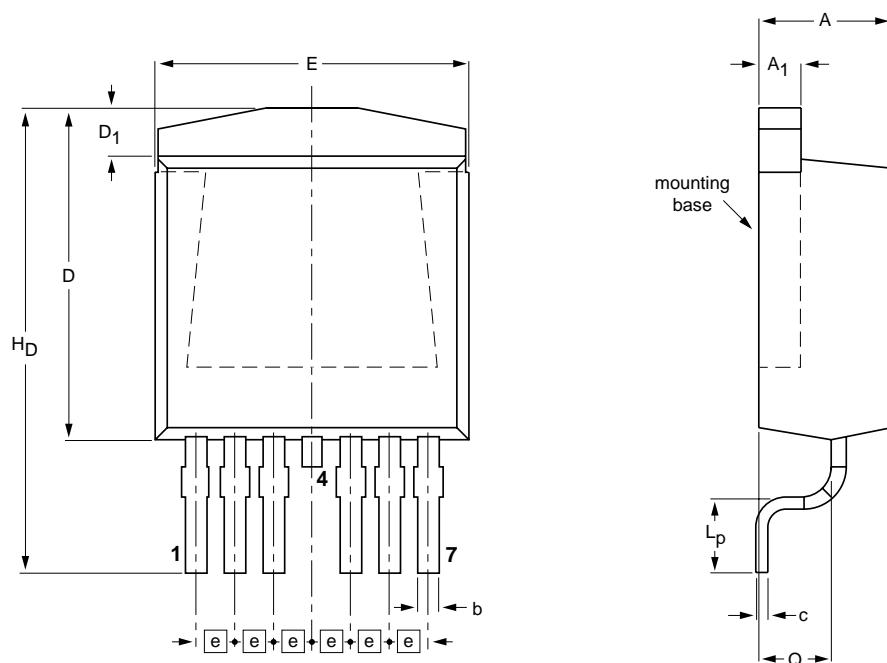
 $V_{GS} = 0$  V

**Fig 18. Source (diode forward) current as function of source-drain (diode forward) voltage; typical values**

## 7. Package outline

Plastic single-ended surface mounted package (D2PAK); 7 leads (one lead cropped)

SOT427



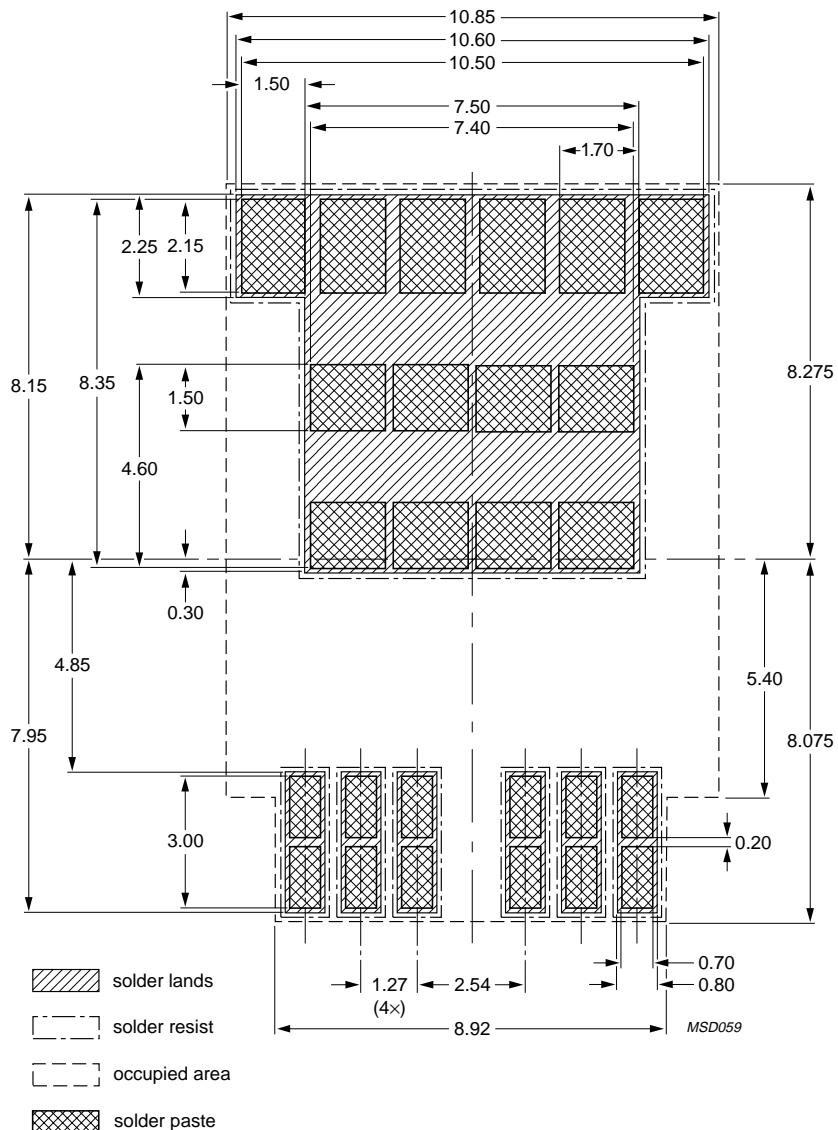
DIMENSIONS (mm are the original dimensions)

UNIT	A	A <sub>1</sub>	b	c	D max.	D <sub>1</sub>	E	e	L <sub>p</sub>	H <sub>D</sub>	Q
mm	4.50 4.10	1.40 1.27	0.85 0.60	0.64 0.46	11	1.60 1.20	10.30 9.70	1.27	2.90 2.10	15.80 14.80	2.60 2.20

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT427						-04-10-13 05-03-09

Fig 19. Package outline SOT427 (D2PAK)

## 8. Soldering



**Fig 20. Reflow soldering footprint for SOT427**

## 9. Revision history

**Table 6: Revision history**

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
BUK7C06-40AITE_4	20050623	Product data sheet	-	-	BUK7C06-40AITE_3
Modifications:					<ul style="list-style-type: none"> <li>• <a href="#">Figure 16</a>: graph corrected</li> </ul>
BUK7C06-40AITE_3	20050616	Product data sheet	-	9397 750 15176	BUK7C06_40AITE-02
Modifications:					<ul style="list-style-type: none"> <li>• The format of this data sheet has been redesigned to comply with the new presentation and information standard of Philips Semiconductors.</li> <li>• <a href="#">Section 1 "Product profile"</a> and <a href="#">Table 5</a>: <math>I_D/I_{sense}</math> values changed.</li> <li>• <a href="#">Figure 17</a>: graph changed.</li> </ul>
BUK7C06_40AITE-02	20040129	Product data	-	9397 750 12487	BUK7C06_40AITE-01
Modifications:					<ul style="list-style-type: none"> <li>• Section 3 "Ordering information" added</li> <li>• Section 1 and Table 5: <math>R_{DSon}</math> typical value changed</li> <li>• Section 1 and Table 5: <math>I_D/I_{sense}</math> typical value changed</li> <li>• Table 5: <math>Q_g(tot)</math>, <math>Q_{gs}</math> and <math>Q_{gd}</math> typical values changed</li> <li>• Table 5: <math>C_{iss}</math>, <math>C_{oss}</math> and <math>C_{rss}</math> typical values changed</li> <li>• Figure 5, 6, 7, 11, 13, 17, 18: graphs changed</li> </ul>
BUK7C06_40AITE-01	20020717	Product data	-	9397 750 09873	-

## 10. Data sheet status

Level	Data sheet status [1]	Product status [2][3]	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
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[1] Please consult the most recently issued data sheet before initiating or completing a design.

[2] The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.

[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

## 11. Definitions

**Short-form specification** — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

**Limiting values definition** — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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**TrenchMOS** — is a trademark of Koninklijke Philips Electronics N.V.

## 12. Disclaimers

**Life support** — These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors

## 14. Contact information

For additional information, please visit: <http://www.semiconductors.philips.com>

For sales office addresses, send an email to: [sales.addresses@www.semiconductors.philips.com](mailto:sales.addresses@www.semiconductors.philips.com)



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Document number: BUK7C06-40AITE\_4

Published in The Netherlands